## Notice of References Cited Application/Control No. O9/754,831 Examiner Elizabeth C. Kemmerer, Ph.D. Applicant(s)/Patent Under Reexamination OPPERMANN ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,261,835	07-2001	Oppermann et al.	435/320.1
	В	US-5,585,237	12-1996	Oppermann et al.	435/6
	С	US-5,614,385	03-1997	Oppermann et al.	435/69.4
	D	US-5,652,118	07-1997	Ozkaynak et al.	435/69.1
	E	US-5,670,336	09-1997	Oppermann et al.	435/69.1
	F	US-5,712,119	01-1998	Oppermann et al.	435/69.4
	G	US-5,863,758	01-1999	Oppermann et al.	435/69.1
	Н	US-6,071,695	06-2000	Ozkaynak et al.	435/6
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	for the Lith Atic Office when Con MDED 5 707 OF (a) \

<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.